Search Notes

Applicat	ion/	Control	No.

10/750,250 Examiner

Caridad M. Everhart

Appl	icant(s	)/Patent	unde
Reev	ramina	lion	

HAN ET AL.

Art Unit

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SEARCHED			
Class	Subclass	Date	Examiner
438	424	3/31/2005	СМЕ
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST:(trench and (pad same spacers) and implant\$7)	3/31/2005	CME .
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